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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

of

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Sheet

Complete if Known		
Application Number	10/821,548	
Filing Date	04/09/2004	
First Named Inventor	Robert Harold Bateman	
Art Unit	2881	
Examiner Name	Unknown	
Attorney Docket Number	AE-MM-11 (MST-1237 US2)	

Examiner Initials*	Cite No.1	Document Number  Number-Kind Code <sup>2 (# kneen)</sup>	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
Bu	B1	<sup>US-</sup> 6,229,142	08-08-2001	Bateman et al.	
Ben	B2	<sup>US-</sup> 6,373,052	04-16-2002	Hoyes et al.	
Pas	В3	<sup>US-</sup> 6,437,325	08-20-2002	Reilly et at.	
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		FORE	IGN PATENT DOCU	IMENTS		
Examiner Initials*	Cite No.1	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	
		Country Code <sup>3</sup> "Number <sup>4</sup> "Kind Code <sup>3</sup> (if known)				1.0
her	C1	EP 1 542 002 A1	06-15-2005	NATSUME, Tohru		
bis	C2	JP 62124456	06-05-1987	JEOL LTD		
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant. Applicant's unique citation designation number (optional). See Kinds Codes of USPTO Patent Documents at <a href="https://www.uspto.gov">www.uspto.gov</a> or MPEP 901.04. Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. Applicant is to place a check mark here if English language Translation is attached.

Iransiation is attached.

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ATTY. DOCKET NO. AE-MM-11 (MST 1237 US2)

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Applicant: Bateman, et al

Filed: April 9, 2004

Serial No: 10/821,548

Entitled: Mass Spectrometer

Examiners Initials CITE No. U.S. Patent

Name of Patentee or Applicant

of Cited Document

Date of Patent

Issued/Published

Class/Sublclass

## References / Papers

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AA Estimating The Precision Of Exact Mass Measurements On An Orthogonal Time of Flight Mass Spectrometer. Karl F. Blom, Anal. Chem. 2001, 73,715-719

<u>be</u>1

AB Statistics. A Guide To The Use Of Statistical Methods in the Physical Sciences. R. J. Barlow, John Wiley & Sons Ltd., Chapter 4 entitled: Errors

ber

AC Statistics. A Guide To The Use Of Statistical Methods in the Physical Sciences. R. J. Barlow, John Wiley & Sons Ltd., Chapter 7, entitled: Probability and Confidence.

Date Considered:

**Examiners Signature**